



#### N-Channel 12-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
	0.0017 at V <sub>GS</sub> = 4.5 V	50				
12	0.002 at V <sub>GS</sub> = 2.5 V	46	56 nC			
	0.0027 at V <sub>GS</sub> = 1.8 V	40				

## SO-8 S 1 8 D S 2 7 D S 3 6 D G 4 5 D

Ordering Information: Si4448DY-T1-E3 (Lead (Pb)-free)

Si4448DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

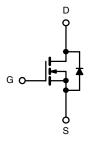
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested



#### **APPLICATIONS**

- POL
- DC/DC



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	<b>S</b> T <sub>A</sub> = 25 °C, unles	ss otherwise no	ted	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	12	v	
Gate-Source Voltage	V <sub>GS</sub>	± 8		
	T <sub>C</sub> = 25 °C		50	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 70 °C	1-	40	
Continuous Diain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	32 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		26 <sup>b, c</sup>	^
Pulsed Drain Current	I <sub>DM</sub>	70	A	
Continuous Course Drain Diade Current	T <sub>C</sub> = 25 °C	I-	7	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	3 <sup>b, c</sup>	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	20	
Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	20	mJ
	T <sub>C</sub> = 25 °C		7.8	
Maximum Dawar Dissination	T <sub>C</sub> = 70 °C	PD	5.0	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	LD	3.5 <sup>b, c</sup>	vv
	T <sub>A</sub> = 70 °C		2.2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	29	35	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	13	16	O/ <b>VV</b>	

#### Notes:

- a. Based on  $T_C$  = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 80 °C/W.

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SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				T	T	1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	12			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		14		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 3.3			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.4		1.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA	
Zoro Cata Valtago Brain Current	lana	V <sub>DS</sub> = 12 V, V <sub>GS</sub> = 0 V	1		1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	- μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	40			Α	
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0014	0.0017	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 15 A		0.0016	0.0020		
		V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 10 A		0.0022	0.0027		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 6 V, I <sub>D</sub> = 20 A		190		S	
Dynamic <sup>b</sup>					l		
Input Capacitance	C <sub>iss</sub>			12350		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 6 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		2775			
Reverse Transfer Capacitance	C <sub>rss</sub>	, bs / ds /		1590			
norono nanon capachane	Qg	V <sub>DS</sub> = 6 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		99	150		
Total Gate Charge		103 0 1, 103 110 1, 10 1011		56	85		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 6 \text{ V}, V_{GS} = 2.5 \text{ V}, I_{D} = 10 \text{ A}$		10.3		nC	
Gate-Drain Charge	Q <sub>gd</sub>			13.4		†	
Gate Resistance	R <sub>g</sub>	f = 1 MHz		0.75	1.5	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			38	70		
Rise Time	t <sub>r</sub>	$V_{DD} = 6 \text{ V}, R_{I} = 0.6 \Omega$		22	40		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		240	400	1	
Fall Time	t <sub>f</sub>	J J J J J J J J J J J J J J J J J J J		33	55		
Turn-On Delay Time	t <sub>d(on)</sub>			20	40	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 6 \text{ V}, R_{L} = 0.6 \Omega$		11	22	-	
Turn-Off Delay Time	-	$I_D \cong 10 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		100	170		
Fall Time	t <sub>d(off)</sub>	D = 1-1-9 - GEN 0 19 132		11	22	-	
Drain-Source Body Diode Characteristic	· ·			11			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			7		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	10 25 5			70	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 3 A		0.54	1.1	V	
Body Diode Voltage  Body Diode Reverse Recovery Time		18 - 0 17		84	140		
	t <sub>rr</sub>			-		ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		93	150	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			28		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			56	1		

#### Notes:

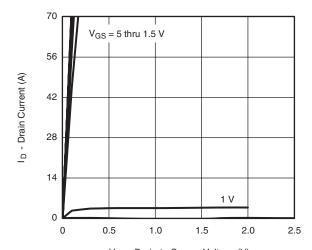
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

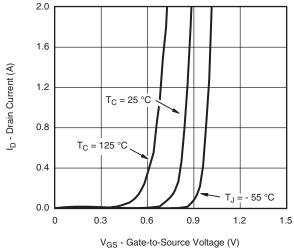
b. Guaranteed by design, not subject to production testing.



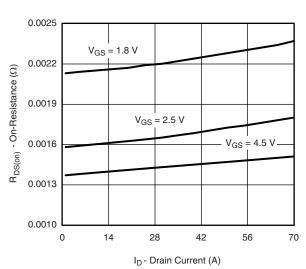
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



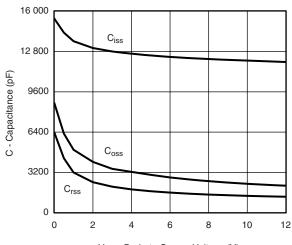
V<sub>DS</sub> - Drain-to-Source Voltage (V) **Output Characteristics** 



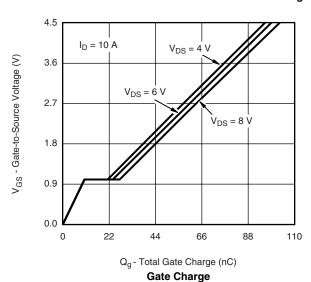
Transfer Characteristics

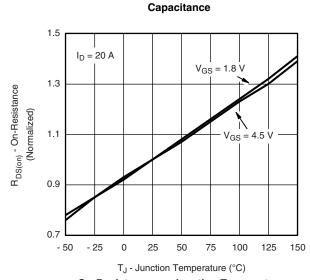


On-Resistance vs. Drain Current and Gate Voltage



V<sub>DS</sub> - Drain-to-Source Voltage (V)



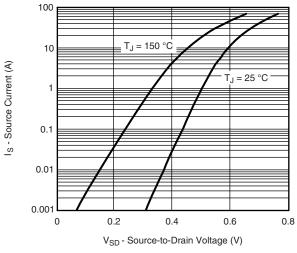


On-Resistance vs. Junction Temperature

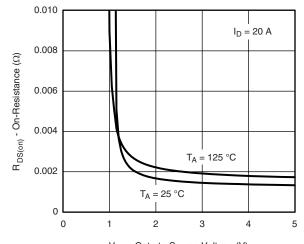
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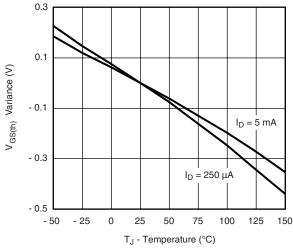
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



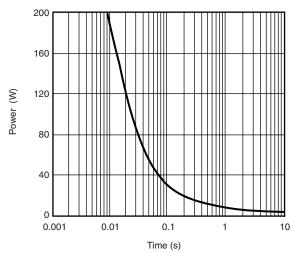
Source-Drain Diode Forward Voltage



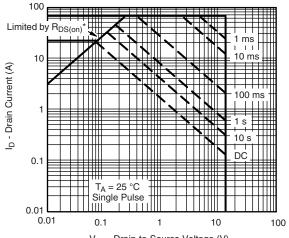
 $\label{eq:VGS} V_{GS} \mbox{ - Gate-to-Source Voltage (V)} \\$  On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



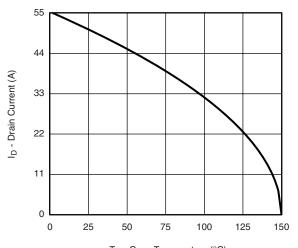
V<sub>DS</sub> - Drain-to-Source Voltage (V)

\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

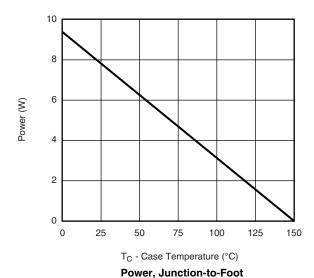


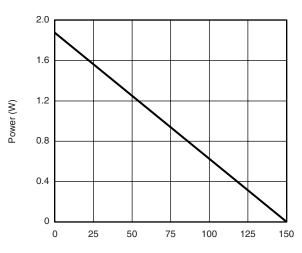
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 $T_{\mbox{\scriptsize C}}$  - Case Temperature (°C)

#### **Current Derating\***





T<sub>A</sub> - Ambient Temperature (°C)

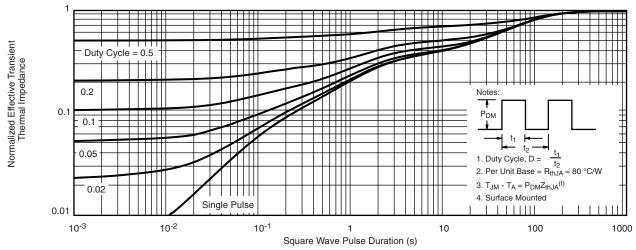
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

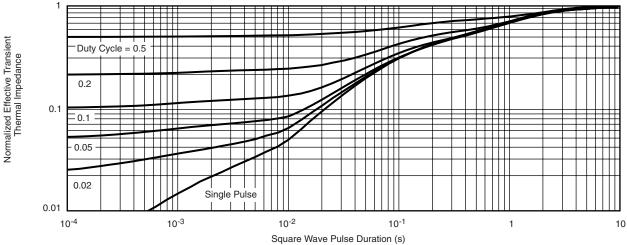
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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Normalized Thermal Transient Impedance, Junction-to-Ambient



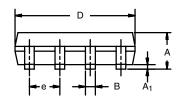
Normalized Thermal Transient Impedance, Junction-to-Foot

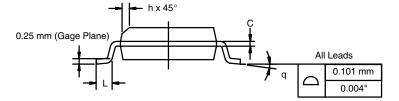
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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	MILLIMETERS INCHES				
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
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DWG: 5498

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# APPLICATION NOTE



#### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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